# Notice of References Cited Application/Control No. 10/584,256 Examiner Daniel Pihulic Applicant(s)/Patent Under Reexamination ISHII ET AL. Page 1 of 2

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,652,589 A	07-1997	Ono et al.	342/70
*	В	US-5,751,240 A	05-1998	Fujita et al.	342/70
*	С	US-6,072,422 A	06-2000	Yamada, Yukinori	342/70
*	D	US-6,121,917 A	09-2000	Yamada, Yukinori	342/109
*	Е	US-6,204,803 B1	03-2001	Uehara, Naohisa	342/70
*	F	US-2002/0180633 A1	12-2002	Nakanishi et al.	342/70
*	G	US-2003/0048216 A1	03-2003	Kishida, Masayuki	342/70
*	Н	US-6,573,859 B2	06-2003	Tokoro, Setsuo	342/70
*	-	US-2003/0128156 A1	07-2003	Kishida, Masayuki	342/195
*	J	US-2003/0122702 A1	07-2003	Kishida et al.	342/70
*	K	US-6,674,393 B2	01-2004	Kishida, Masayuki	342/70
*	L	US-6,690,319 B2	02-2004	Matsui et al.	342/70
*	М	US-2004/0125010 A1	07-2004	Natsume et al.	342/070

## **FOREIGN PATENT DOCUMENTS**

*	i	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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## **NON-PATENT DOCUMENTS**

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# Notice of References Cited

Application/Control No. 10/584,256	Applicant(s)/Patent Under Reexamination ISHII ET AL.			
Examiner	Art Unit			
Daniel Pihulic	3662	Page 2 of 2		

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0183719 A1	09-2004	Natsume et al.	342/147
*	В	US-2004/0222919 A1	11-2004	Isaji, Osamu	342/070
*	С	US-2005/0165567 A1	07-2005	Inatsune, Shigeho	702/066
*	D	US-2005/0156780 A1	07-2005	Bonthron et al.	342/070
*	Е	US-7,034,743 B2	04-2006	Nakanishi et al.	342/109
*	F	US-7,034,745 B2	04-2006	Isaji, Osamu	342/109
*	G	US-7,061,424 B2	06-2006	Kuroda et al.	342/70
*	Н	US-7,151,482 B2	12-2006	Natsume et al.	342/195
*	ı	US-7,196,658 B2	03-2007	Inatsune, Shigeho	342/195
*	J	US-7,242,344 B2	07-2007	Mitsumoto, Masashi	342/70
*	К	US-2007/0153255 A1	07-2007	Ishii et al.	356/028
	L	US-			
	М	US-			

# FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

	NON-FATENT DOCUMENTS			
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.